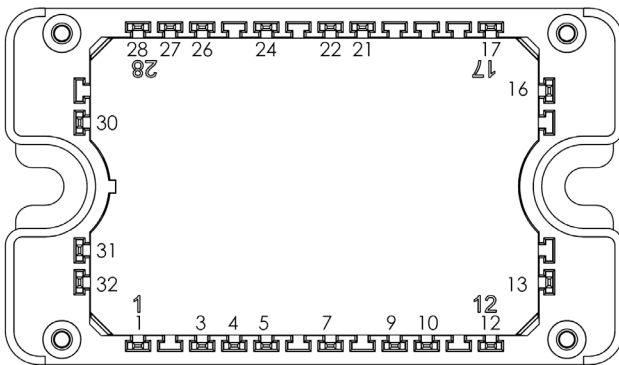
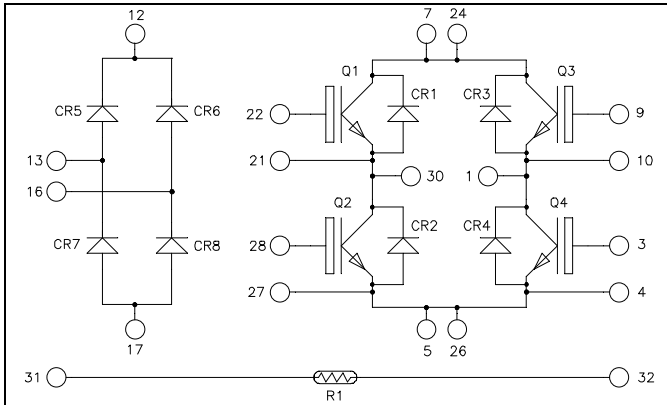


**Full bridge + rectifier bridge  
Trench + Field Stop IGBT3  
Power Module**

**$V_{CES} = 600V$   
 $I_C = 50A @ T_c = 80^\circ C$**



All multiple inputs and outputs must be shorted together  
7/24 ; 5/26

**Application**

- Solar converter

**Features**

- Trench + Field Stop IGBT3 Technology
  - Low voltage drop
  - Low tail current
  - Switching frequency up to 20 kHz
  - Soft recovery parallel diodes
  - Low diode VF
  - Low leakage current
  - RBSOA and SCSOA rated
- Kelvin emitter for easy drive
- Very low stray inductance
- High level of integration
- Internal thermistor for temperature monitoring

**Benefits**

- Stable temperature behavior
- Very rugged
- Solderable terminals both for power and signal for easy PCB mounting
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive TC of  $V_{CESat}$
- Low profile
- RoHS Compliant

**All ratings @  $T_j = 25^\circ C$  unless otherwise specified**

**CAUTION:** These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on [www.microsemi.com](http://www.microsemi.com)

## 1. Full bridge

### Absolute maximum ratings (per IGBT)

Symbol	Parameter	Max ratings	Unit
V <sub>CES</sub>	Collector - Emitter Breakdown Voltage	600	V
I <sub>C</sub>	Continuous Collector Current	T <sub>C</sub> = 25°C	80
		T <sub>C</sub> = 80°C	50
I <sub>CM</sub>	Pulsed Collector Current	T <sub>C</sub> = 25°C	100
V <sub>GE</sub>	Gate - Emitter Voltage	±20	V
P <sub>D</sub>	Maximum Power Dissipation	T <sub>C</sub> = 25°C	176
RBSOA	Reverse Bias Safe Operating Area	T <sub>J</sub> = 150°C	100A @ 550V

### Electrical Characteristics (per IGBT)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
I <sub>CES</sub>	Zero Gate Voltage Collector Current	V <sub>GE</sub> = 0V, V <sub>CE</sub> = 600V			250	μA
V <sub>CE(sat)</sub>	Collector Emitter Saturation Voltage	V <sub>GE</sub> = 15V		1.5	1.9	V
		I <sub>C</sub> = 50A	T <sub>J</sub> = 25°C			
V <sub>GE(th)</sub>	Gate Threshold Voltage	V <sub>GE</sub> = V <sub>CE</sub> , I <sub>C</sub> = 600μA	5.0	5.8	6.5	V
I <sub>GES</sub>	Gate - Emitter Leakage Current	V <sub>GE</sub> = 20V, V <sub>CE</sub> = 0V			600	nA

### Dynamic Characteristics (per IGBT)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
C <sub>ies</sub>	Input Capacitance	V <sub>GE</sub> = 0V V <sub>CE</sub> = 25V f = 1MHz		3150		pF
C <sub>oes</sub>	Output Capacitance			200		
C <sub>res</sub>	Reverse Transfer Capacitance			95		
Q <sub>G</sub>	Gate charge	V <sub>GE</sub> = ±15V, I <sub>C</sub> = 50A V <sub>CE</sub> = 300V		0.5		μC
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switching (25°C) V <sub>GE</sub> = ±15V V <sub>Bus</sub> = 300V I <sub>C</sub> = 50A R <sub>G</sub> = 8.2Ω		110		ns
T <sub>r</sub>	Rise Time			45		
T <sub>d(off)</sub>	Turn-off Delay Time			200		
T <sub>f</sub>	Fall Time			40		
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switching (150°C) V <sub>GE</sub> = ±15V V <sub>Bus</sub> = 300V I <sub>C</sub> = 50A R <sub>G</sub> = 8.2Ω		120		ns
T <sub>r</sub>	Rise Time			50		
T <sub>d(off)</sub>	Turn-off Delay Time			250		
T <sub>f</sub>	Fall Time			60		
E <sub>on</sub>	Turn-on Switching Energy	V <sub>GE</sub> = ±15V V <sub>Bus</sub> = 300V I <sub>C</sub> = 50A	T <sub>J</sub> = 25°C	0.3		mJ
			T <sub>J</sub> = 150°C	0.43		
E <sub>off</sub>	Turn-off Switching Energy	R <sub>G</sub> = 8.2Ω	T <sub>J</sub> = 25°C	1.35		mJ
			T <sub>J</sub> = 150°C	1.75		
I <sub>sc</sub>	Short Circuit data	V <sub>GE</sub> ≤ 15V ; V <sub>Bus</sub> = 360V t <sub>p</sub> ≤ 6μs ; T <sub>J</sub> = 150°C		250		A
R <sub>thJC</sub>	Junction to Case Thermal Resistance				0.85	°C/W

**Reverse diode ratings and characteristics** (per diode)

<i>Symbol</i>	<i>Characteristic</i>	<i>Test Conditions</i>		<i>Min</i>	<i>Typ</i>	<i>Max</i>	<i>Unit</i>
V <sub>RRM</sub>	Maximum Peak Repetitive Reverse Voltage			600			V
I <sub>RM</sub>	Maximum Reverse Leakage Current	V <sub>R</sub> =600V	T <sub>j</sub> = 25°C			250	μA
			T <sub>j</sub> = 150°C			500	
I <sub>F</sub>	DC Forward Current		T <sub>c</sub> = 80°C		50		A
V <sub>F</sub>	Diode Forward Voltage	I <sub>F</sub> = 50A V <sub>GE</sub> = 0V	T <sub>j</sub> = 25°C		1.6	2	V
			T <sub>j</sub> = 150°C		1.5		
t <sub>rr</sub>	Reverse Recovery Time		T <sub>j</sub> = 25°C		100		ns
			T <sub>j</sub> = 150°C		150		
Q <sub>rr</sub>	Reverse Recovery Charge	I <sub>F</sub> = 50A V <sub>R</sub> = 300V di/dt = 1800A/μs	T <sub>j</sub> = 25°C		2.6		μC
			T <sub>j</sub> = 150°C		5.4		
E <sub>rr</sub>	Reverse Recovery Energy		T <sub>j</sub> = 25°C		0.6		mJ
			T <sub>j</sub> = 150°C		1.2		
R <sub>thJC</sub>	Junction to Case Thermal Resistance					1.42	°C/W

## 2. Rectifier bridge

**Absolute maximum ratings** (per diode)

<i>Symbol</i>	<i>Parameter</i>			<i>Max ratings</i>	<i>Unit</i>
V <sub>R</sub>	Maximum DC reverse Voltage			600	V
V <sub>RRM</sub>	Maximum Peak Repetitive Reverse Voltage				
I <sub>F(AV)</sub>	Maximum Average Forward Current	Duty cycle = 50%	T <sub>C</sub> = 80°C	40	A
I <sub>FSM</sub>	Non-Repetitive Forward Surge Current	8.3ms	T <sub>J</sub> = 45°C	320	

**Electrical Characteristics** (per diode)

<i>Symbol</i>	<i>Characteristic</i>	<i>Test Conditions</i>		<i>Min</i>	<i>Typ</i>	<i>Max</i>	<i>Unit</i>
V <sub>F</sub>	Diode Forward Voltage	I <sub>F</sub> = 30A			1.8	2.2	V
		I <sub>F</sub> = 60A			2.2		
		I <sub>F</sub> = 30A	T <sub>j</sub> = 125°C		1.5		
I <sub>RM</sub>	Maximum Reverse Leakage Current	V <sub>R</sub> = 600V	T <sub>j</sub> = 25°C			250	μA
			T <sub>j</sub> = 125°C			500	

**Dynamic Characteristics** (per diode)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
$t_{rr}$	Reverse Recovery Time	$I_F=1A, V_R=30V$ $di/dt = 100A/\mu s$	$T_j = 25^\circ C$		22		ns
$t_{rr}$	Reverse Recovery Time	$I_F = 30A$ $V_R = 400V$ $di/dt = 200A/\mu s$	$T_j = 25^\circ C$		25		ns
			$T_j = 125^\circ C$		160		
$Q_{rr}$	Reverse Recovery Charge		$T_j = 25^\circ C$		35		nC
			$T_j = 125^\circ C$		480		
$I_{RRM}$	Reverse Recovery Current		$T_j = 25^\circ C$		3		A
		$T_j = 125^\circ C$		6			
$t_{rr}$	Reverse Recovery Time	$I_F = 30A$ $V_R = 400V$ $di/dt = 1000A/\mu s$	$T_j = 125^\circ C$		85		ns
$Q_{rr}$	Reverse Recovery Charge				920		$\mu C$
$I_{RRM}$	Reverse Recovery Current				20		A
$R_{thJC}$	Junction to Case Thermal Resistance					1.2	$^\circ C/W$

**3. Thermal and package characteristics**
**Temperature sensor NTC** (see application note APT0406 on www.microsemi.com for more information).

Symbol	Characteristic	Min	Typ	Max	Unit
$R_{25}$	Resistance @ 25°C		50		k $\Omega$
$\Delta R_{25}/R_{25}$			5		%
$B_{25/85}$	$T_{25} = 298.15 K$		3952		K
$\Delta B/B$	$T_C = 100^\circ C$		4		%

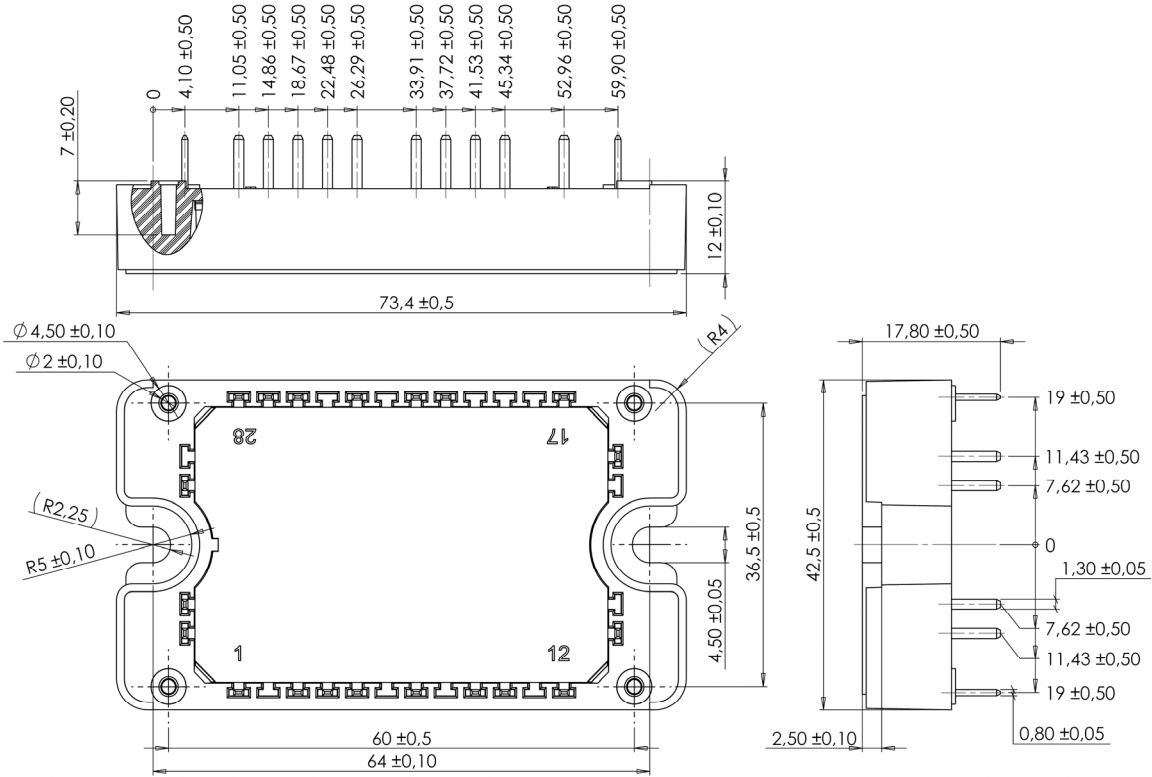
$$R_T = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$

T: Thermistor temperature  
 $R_T$ : Thermistor value at T

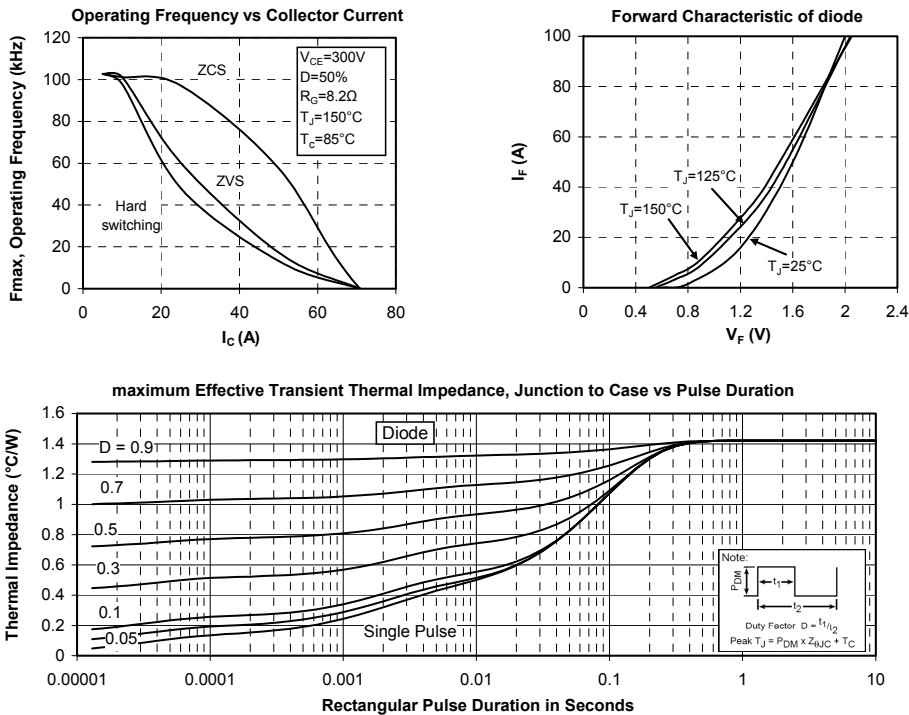
**Package characteristics**

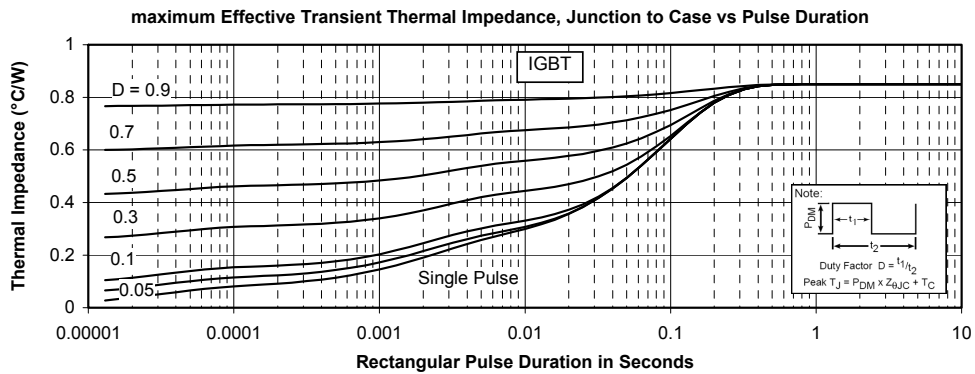
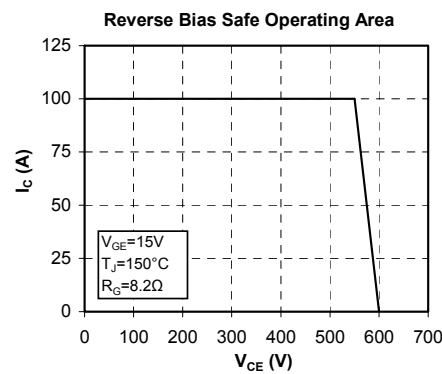
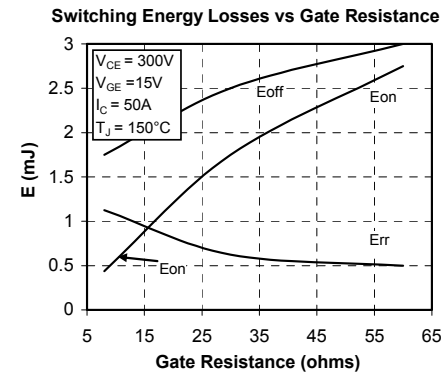
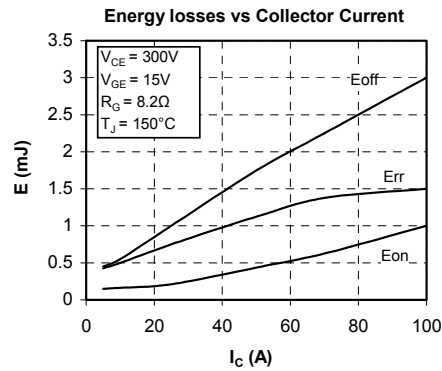
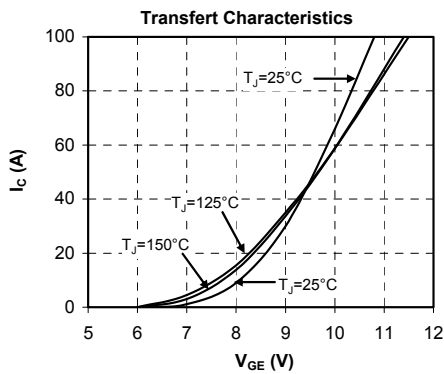
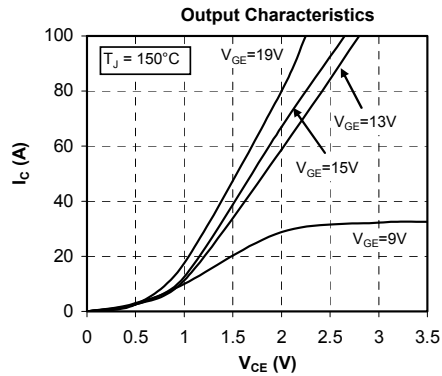
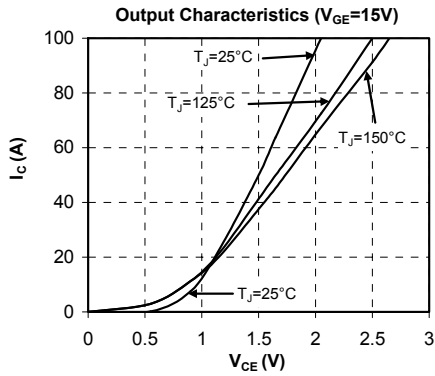
Symbol	Characteristic	Min	Typ	Max	Unit	
$V_{ISOL}$	RMS Isolation Voltage, any terminal to case t=1 min, 50/60Hz	4000			V	
$T_J$	Operating junction temperature range	-40		175	$^\circ C$	
$T_{STG}$	Storage Temperature Range	-40		125		
$T_C$	Operating Case Temperature	-40		100		
Torque	Mounting torque	To heatsink	M4	2	3	N.m
Wt	Package Weight				110	g

## SP3 Package outline (dimensions in mm)

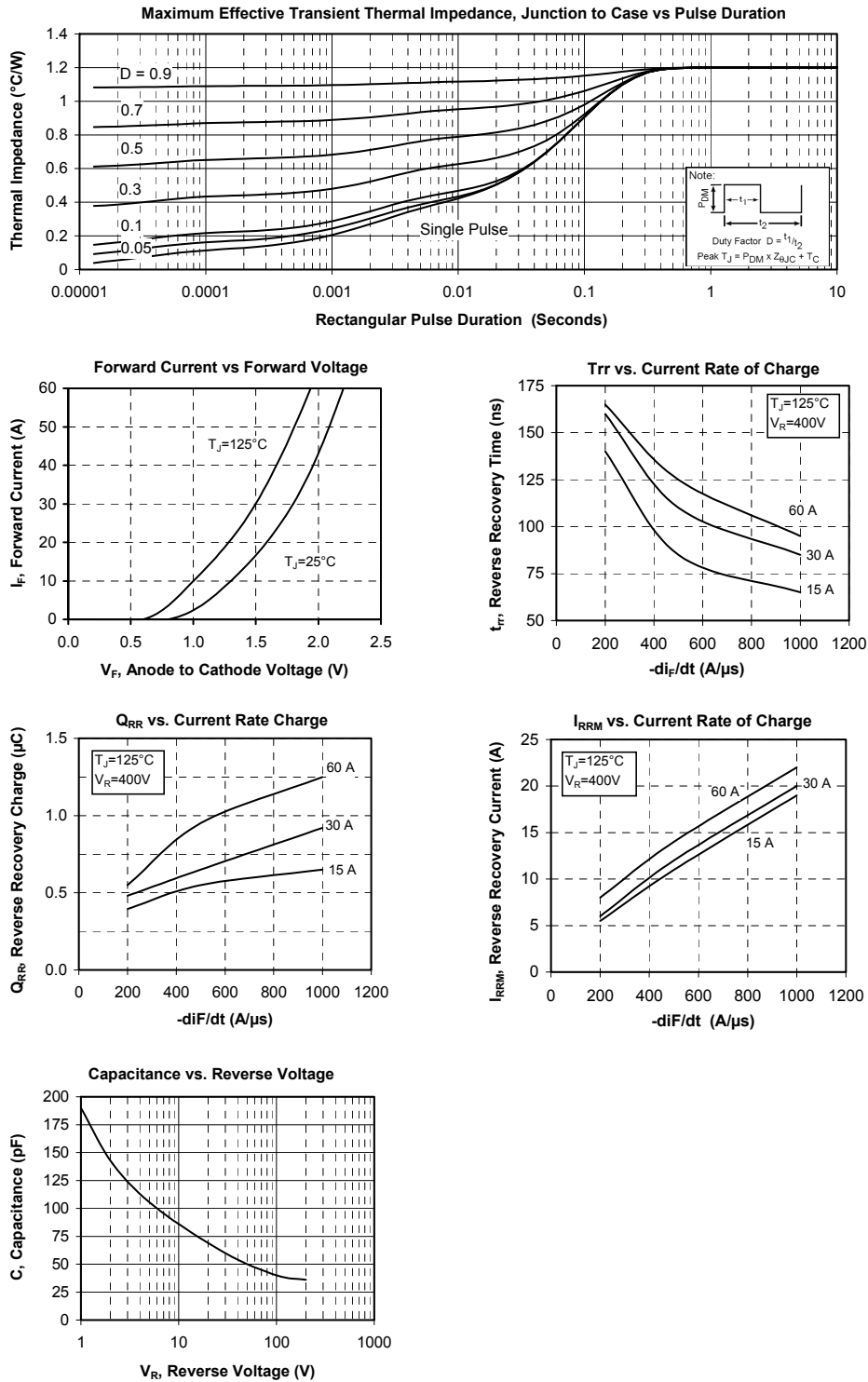


## 4. Typical full bridge Performance Curve (per IGBT and parallel diode)





## 5. Typical rectifier bridge Performance Curve (per diode)



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